

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

CLAIM AMENDMENTS

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

Claim 1 (currently amended). A circuit configuration in switched op-amp technology, comprising:

at least one switchable operational amplifier having an input and an output and transistors having a switching speed;

at least one sampling capacitor connected to said input;

at least one integrating capacitor connected to said input and to said output;

a detector for detecting the switching speed of said transistors, said detector being connected to said operational amplifier;

a clock generator producing a first and a second switching signal at least two non-overlapping switching-clock signals each having switching-clock phases including an on-phase and an off-phase, the on-phases of said first and said second switching clock signal being non-overlapping;

Appl. No. 09/932,891  
Amdt. Dated September 23, 2004  
Reply to Office Action of June 23, 2004

~~said at least two non-overlapping switching-clock signals  
including a first switching-clock signal and a second  
switching-clock signal;~~

said clock generator controlling charging of said sampling  
capacitor with said first switching-clock signal and switching  
said operational amplifier on and off with said second  
switching-clock signal; and

a phase-variance device varying said switching-clock phases in  
which said first and second switching-clock signals are in  
said off-phase, said phase-variance device connected to said  
clock generator.

Claim 2 (original). The circuit configuration according to  
claim 1, wherein said phase-variance device is configured to  
vary each of said switching-clock phases in which said first  
and second switching-clock signals are in said off-phase.

Claim 3 (original). The circuit configuration according to  
claim 1, wherein said phase-variance device is configured to  
vary each second one of said switching-clock phases in which  
said first and second switching-clock signals are in said off-  
phase.

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

Claim 4 (original). The circuit configuration according to claim 1, wherein:

said operational amplifier has a transient response; and

said phase-variance device is configured to vary a duration of said switching-clock phases in which said first and second switching-clock signals are in said off-phase dependent upon said transient response of said operational amplifier.

Claim 5 (original). The circuit configuration according to claim 1, wherein:

said operational amplifier has transistors having a switching speed; and

said phase-variance device is configured to vary a duration of said switching-clock phases in which said first and second switching-clock signals are in said off-phase dependent upon said switching speed of said transistors.

Claim 6 (canceled).

Claim 7 (currently amended). The circuit configuration according to claim 6 1, wherein:

Appl. No. 09/932,891  
Amdt. Dated September 23, 2004  
Reply to Office Action of June 23, 2004

said transistors include at least one of:

n-channel FETs; and

p-channel FETs;

said transistors each have a respective switching speed; and

said detector separately detects said switching speed of said n-channel FETs and said p-channel FETs.

Claim 8 (currently amended). The circuit configuration according to claim 6 1, including an inverter chain, said detector having one of:

an XOR gate with XOR inputs, one of said XOR inputs receiving an undelayed edge signal, and another of said XOR inputs receiving the edge signal delayed through said inverter chain; and

an XNOR gate with XNOR inputs, one of said XNOR inputs receiving the edge signal and another of said XNOR inputs receiving the edge signal delayed through said inverter chain.

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

Claim 9 (currently amended). The circuit configuration according to claim ~~6~~ 1, wherein said detector generates detector pulses having a duration characterizing said switching speed of said transistors.

Claim 10 (original). The circuit configuration according to claim 9, wherein said phase-variance device is configured to adjust a duration of said switching-clock phases in which said first and second switching-clock signals are in said off-phase dependent upon a duration of said detector pulses.

Claim 11 (original). The circuit configuration according to claim 1, wherein said phase-variance device is configured to adjust a duration of said switching-clock phases in which said first and second switching-clock signals are in said off-phase in a given number of predetermined steps.

Claim 12 (original). The circuit configuration according to claim 1, wherein said clock generator and said phase-variance device are embodied as a programmable clock generator.

Claim 13 (original). The circuit configuration according to claim 1, wherein said clock generator and said phase-variance device are embodied as:

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

an external squarewave generator producing a squarewave signal; and

a divider circuit connected to said squarewave generator, said divider circuit generating said at least two switching-clock signals from said squarewave signal.

Claim 14 (original). The circuit configuration according to claim 13, wherein:

said squarewave signal has a duty ratio; and

adjustment of said duty ratio varies said switching-clock phases in which said first and second switching-clock signals are in said off-phase.

Claim 15 (currently amended). A circuit configuration in fully differential circuit technology, comprising:

at least one switchable operational amplifier having an input and an output and transistors having a switching speed;

at least one sampling capacitor connected to said input;

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

at least one integrating capacitor connected to said input and  
to said output;

a detector for detecting the switching speed of said  
transistors, said detector being connected to said operational  
amplifier;

a clock generator producing a first and a second switching  
signal at least two non-overlapping switching-clock signals  
each having switching-clock phases including an on-phase and  
an off-phase, the on-phases of said first and said second  
switching clock signal being non-overlapping;

~~said at least two non-overlapping switching-clock signals  
including a first switching-clock signal and a second  
switching-clock signal;~~

said clock generator controlling charging of said sampling  
capacitor with said first switching-clock signal and switching  
said operational amplifier on and off with said second  
switching-clock signal; and

a phase-variance device varying said switching-clock phases in  
which said first and second switching-clock signals are in

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

said off-phase, said phase-variance device connected to said clock generator.

Claim 16 (currently amended). A circuit configuration in switched op-amp technology, comprising:

at least one switchable operational amplifier having an input and an output and transistors having a switching speed;

at least one sampling capacitor connected to said input;

at least one integrating capacitor connected to said input and to said output;

a detector for detecting the switching speed of said transistors, said detector being connected to said operational amplifier;

a clock generator means for generating a first and a second switching signal at least two non-overlapping switching clock signals each having and an on-phase and an off-phase, the on-phases of said first and said second switching clock signal being non-overlapping;



Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

~~said at least two non-overlapping switching-clock signals  
including a first switching-clock signal and a second  
switching-clock signal;~~

said clock generator means controlling charging of said  
sampling capacitor with said first switching-clock signal and  
switching said operational amplifier on and off with said  
second switching-clock signal; and

a phase-variance means for varying switching-clock phases in  
which said first and second switching-clock signals are in  
said off-phase, said phase-variance means connected to said  
clock generator means.

Claim 17 (currently amended). A method for clocking  
successive operational amplifier stages constructed in  
switched op-amp technology, which comprises:

generating at least two non-overlapping switching-clock  
signals;

switching a first operational amplifier on and off with a  
first signal of the two switching-clock signals;

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

switching a second operational amplifier on and off with a second signal of the switching-clock signals; and

varying switching-clock phases of the first and second signals in which the operational amplifiers are switched off.

Claim 18 (original). The method according to claim 17, which further comprises varying each of the switching-clock phases in which the operational amplifiers are switched off.

Claim 19 (original). The method according to claim 17, which further comprises varying each second one of the switching-clock phases in which the operational amplifiers are switched off.

Claim 20 (original). The method according to claim 17, which further comprises varying a duration of the switching-clock phases in which the operational amplifiers are switched off dependent on a transient response of the operational amplifiers.

Claim 21 (original). The method according to claim 17, which further comprises varying a duration of the switching-clock phases in which the operational amplifiers are switched off

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

dependent on a switching speed of transistors of the operational amplifiers.

Claim 22 (original). The method according to claim 17, which further comprises separately detecting at least one of a switching speed of n-channel FETs and a switching speed of p-channel FETs.

Claim 23 (original). The method according to claim 21, which further comprises separately detecting at least one of a switching speed of n-channel FETs and a switching speed of p-channel FETs.

Claim 24 (original). The method according to claim 17, which further comprises adjusting a duration of the switching-clock phases in which the operational amplifiers are switched off in a number of predetermined steps.

Claim 25 (original). The method according to claim 17, which further comprises generating the at least two non-overlapping switching-clock signals with a programmable clock generator.

Claim 26 (original). The method according to claim 17, which further comprises generating the at least two non-overlapping

Appl. No. 09/932,891

Amdt. Dated September 23, 2004

Reply to Office Action of June 23, 2004

switching-clock signals with an external squarewave generator and a divider circuit.

Claim 27 (original). The method according to claim 26, which further comprises varying the switching-clock phases in which the operational amplifiers are switched off by adjusting a duty ratio of a squarewave signal from the squarewave generator.